

**Search Notes**

Application/Control No.

10/711,999

Examiner

Mathieu D. Vargot

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

1732

**SEARCHED**

Class	Subclass	Date	Examiner
264	1.1, 25, 1.37,		
	400,		
	482	11/9/06	MDV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR